

N-Channel Enhancement Mode Field Effect Transistor

General Description

The AO4414 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance. Standard Product AO4414 is Pb-free (meets ROHS & Sony 259 specifications). AO4414L is a Green Product ordering option. AO4414 and AO4414L are electrically identical.

Features

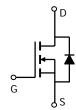
 $V_{DS}(V) = 30V$

 $I_D = 8.5A \ (V_{GS} = 10V)$

 $R_{DS(ON)}$ < 26m Ω (V_{GS} = 10V)

 $R_{DS(ON)}$ < 40m Ω (V_{GS} = 4.5V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	30	V			
Gate-Source Voltage		V_{GS}	±20	V			
Continuous Drain	T _A =25°C		8.5				
Current ^A	T _A =70°C	I _D	7.1	Α			
Pulsed Drain Current ^B		I _{DM}	50				
	T _A =25°C	P _D	3	W			
Power Dissipation	T _A =70°C]' D	2.1	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C			

Thermal Characteristics								
Parameter	Symbol	Тур	Typ Max I					
Maximum Junction-to-Ambient A	t ≤ 10s	В	31	40	°C/W			
Maximum Junction-to-Ambient ^A	Steady-State	$R_{\theta JA}$	59	75	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{ heta JL}$	16	24	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V			0.004	1			
			T _J =55°C			5	μА		
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±20V				100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=250\mu A$		1	1.9	3	V		
I _{D(ON)}	On state drain current	V _{GS} =4.5V, V _{DS} =5V		20			Α		
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =8.5A			20	26	mO		
		Т	J=125°C		29.2	38	mΩ		
		V _{GS} =4.5V, I _D =5A			31	40	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =5A		10	17		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.76	1	V		
Is	Maximum Body-Diode Continuous Current					4.3	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			680	820	pF		
C _{oss}	Output Capacitance				102		pF		
C _{rss}	Reverse Transfer Capacitance				77		pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			3	3.6	Ω		
SWITCHI	NG PARAMETERS								
Q _g (10V)	Total Gate Charge	-V _{GS} =10V, V _{DS} =15V, I _D =8.5A			13.84	17	nC		
Q _g (4.5V)	Total Gate Charge				6.74	8.1	nC		
Q_{gs}	Gate Source Charge				1.84		nC		
Q_{gd}	Gate Drain Charge				3.32		nC		
t _{D(on)}	Turn-On DelayTime				4.5	6.5	ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.8 Ω , R_{GEN} =3 Ω			4.2	6.3	ns		
$t_{D(off)}$	Turn-Off DelayTime				20.1	30	ns		
t _f	Turn-Off Fall Time				4.9	7.5	ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =8.5A, dI/dt=100A/μs			17.2	21	ns		
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =8.5A, dI/dt=100A/μs			8.6	10	nC		

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

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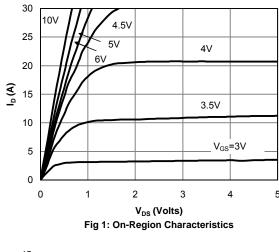
B: Repetitive rating, pulse width limited by junction temperature.

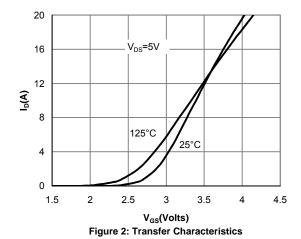
C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

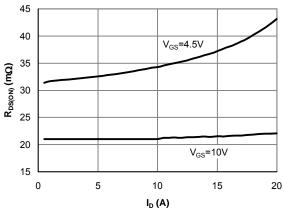
D. The static characteristics in Figures 1 to 6 are obtained using $80\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS







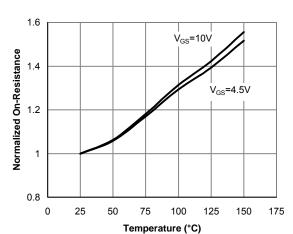
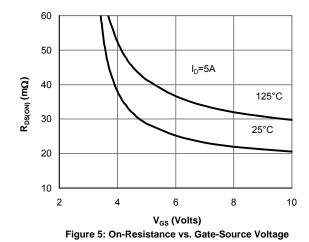
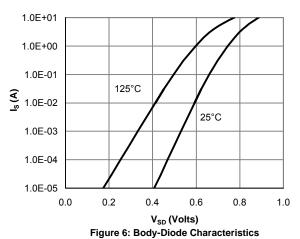


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

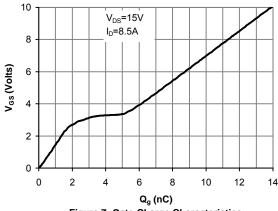


Figure 7: Gate-Charge Characteristics

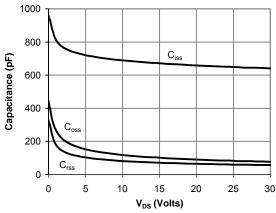


Figure 8: Capacitance Characteristics

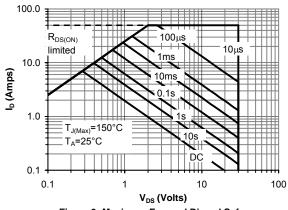


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

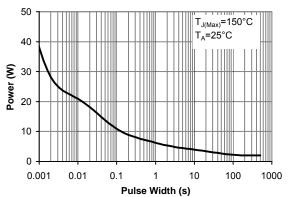


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

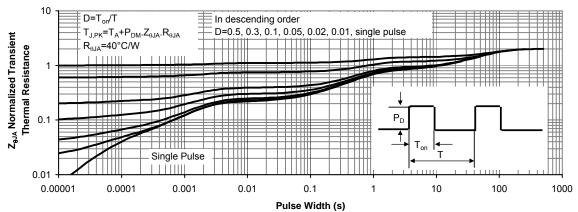


Figure 11: Normalized Maximum Transient Thermal Impedance